Supplementary Figure 2. Sample-level signal intensity mask. Binary masks were calculated

for each subject, at each time point, thresholded at >70% mean signal intensity (Geerligs et al.,

2015), computed over all voxels, using ART (www.nitrc.org/projects/artifact_detect/). Then, a

sample-level mask was calculated, across all subjects and time points, using logical conjunction.

The resulting sample-level mask (red color) is superimposed on the canonical single-subject T1

template part of SPM12, and displayed in coronal (left) and sagittal (right) sections, using

MRIcron (https://www.nitrc.org/projects/mricron/); see Methods section for details.